

1ED3010MC12I, 1ED3011MC12I, 1ED3012MC12I

Single-channel isolated gate driver IC with opto-emulator input

Features

- Single-channel isolated gate driver with opto-compatible input
- Pin-to-Pin compatible, drop-in replacement and upgrade for opto-isolated gate drivers
- For use with IGBTs, Si and SiC MOSFETs
- Up to 6.5 A typical peak output current
- 40 ns propagation delay with 10 ns part-to-part matching (skew)
- 17 ns part to part matching for complementary edges (skew+)
- 35 V absolute maximum output supply voltage
- High common-mode transient immunity CMTI > 300 kV/μs
- Single output with active shutdown and short circuit clamping
- Galvanically isolated coreless transformer gate driver
- Suitable for operation at high ambient temperature and in fast switching applications
- Safety certification:
 - UL 1577 planned with $V_{ISO,test} = 6840$ V (rms) for 1 s, $V_{ISO} = 5700$ V (rms) for 60 s
 - Reinforced insulation according to IEC 60747-17 planned with $V_{IORM} = 1767$ V (peak)



RoHS



Green

Potential applications

- Industrial motor drives
- EV charging
- Energy storage systems
- Solar inverters
- Server and telecom switched mode power supplies (SMPS)
- UPS-systems
- Commercial air-conditioning (CAC)
- High voltage DC-DC converter and DC-AC inverter

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC JESD47, JESD22, and J-STD-020.

Description

The 1ED301xMC12I gate driver ICs are opto-compatible, galvanically isolated single channel gate drivers for IGBT, Si or SiC MOSFET in LDSO-6 300 mil package. They provide a typical output current of up to 6.5 A.

The exceptional common mode transient immunity, low propagation delay with outstanding part-to-part skew and very small pulse width distortion are performance parameters vastly above those of standard opto-coupler based gate drivers. This makes these gate drivers a perfect fit for high performance applications using SiC MOSFETs, while pin-to-pin compatibility offers a simple alternative in IGBT applications with increased reliability.

Data transfer across the isolation barrier is realized by the coreless transformer technology. All variants have output undervoltage lockout (UVLO) and active shutdown.

Description

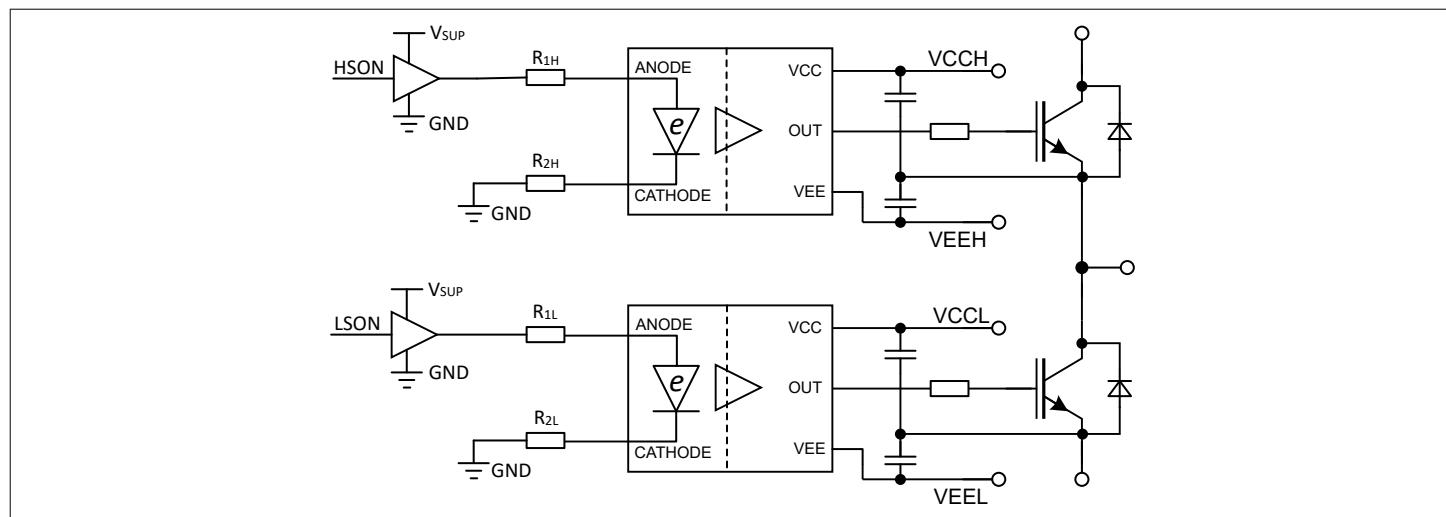


Table 1 Ordering information

Product type	Typical UVLO (V_{UVLOL2}/V_{UVLOH2})	Typical output current source/sink	UL 1577 Certification	IEC 60747-17 Certification	Package marking
1ED3010MC12I	8.5 V/9.3 V	6 A/6.5 A	planned	planned	3010MC12
1ED3011MC12I	11.0 V/12.0 V	6 A/6.5 A	planned	planned	3011MC12
1ED3012MC12I	12.5 V/13.6 V	6 A/6.5 A	planned	planned	3012MC12

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1 Block diagram reference

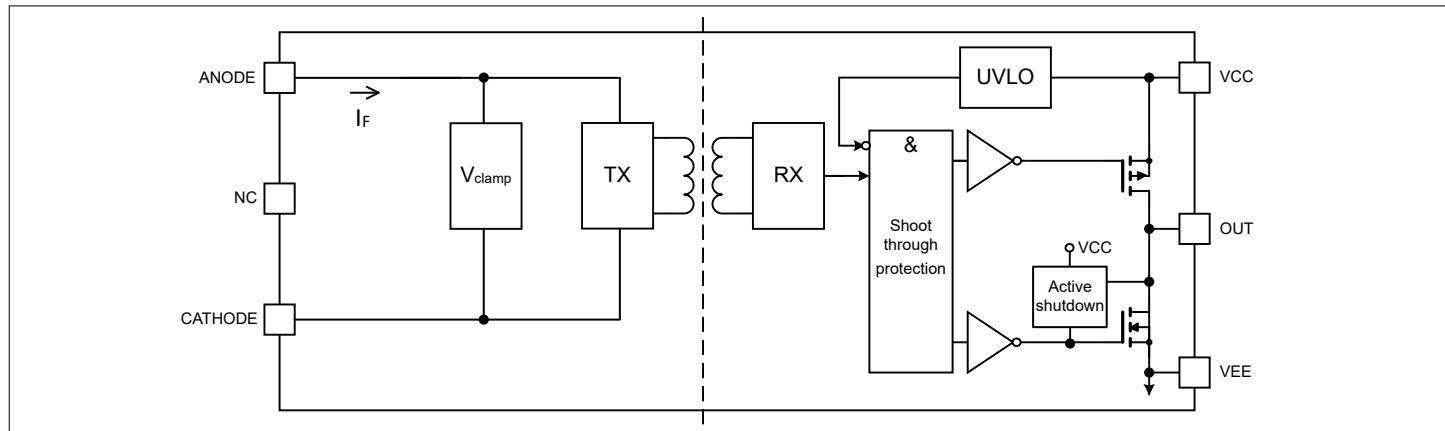


Figure 1 Block diagram

2 Pin configuration and description

Pin configuration LDSO-6 300 mil

Table 2 Pin configuration

Pin No.	Name	Function
1	ANODE	Anode connection of opto-emulator input
2	NC	Not connected
3	CATHODE	Cathode connection of opto-emulator input
4	VEE	Output side ground
5	OUT	Driver output
6	VCC	Positive power supply output side

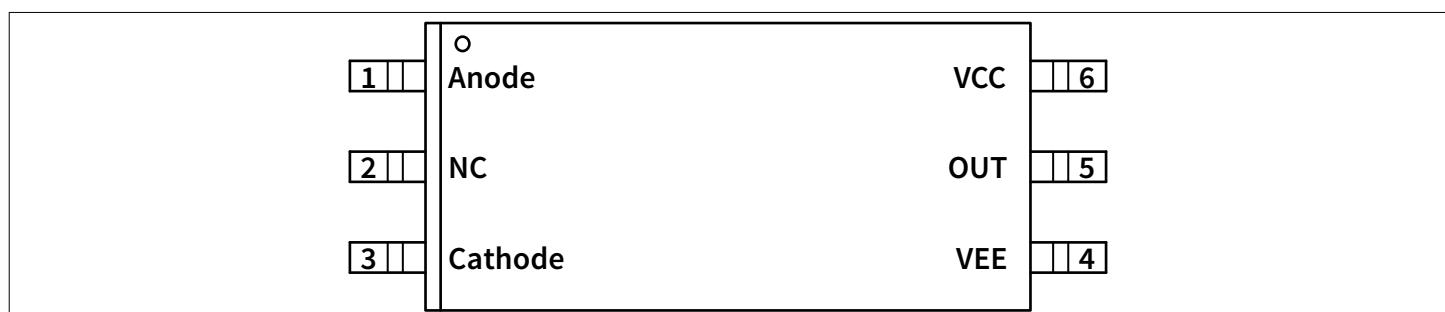


Figure 2 LDSO-6 300 mil (top view)

Pin description

- **ANODE:** Anode connection of the input emulated diode. When forward current is flowing through this emulated diode, the OUTPUT is pulled high
- **CATHODE:** Cathode connection of the input emulated diode. When forward current is flowing through this emulated diode, the OUTPUT is pulled high
- **VCC:** Output positive power supply rail. Connect a decoupling capacitor from this pin to VEE. Use a low ESR and ESL capacitor placed as close to the device as possible

3 Electrical characteristics and parameters

- VEE : Output ground. All the output side signals, VCC and OUT , are referenced to this ground. In case of a bipolar supply (positive and negative voltage referred to IGBT emitter or MOSFET source), this pin should be connected to the negative supply voltage
- OUT : Driver output pin used to charge and discharge the gate of the external transistor (IGBT or MOSFET). During ON-state this output is connected to VCC . During OFF-state this output is connected to VEE . This output is controlled by $ANODE$ and $CATHODE$. In case of an UVLO event OUT will be actively pulled low. For cases where the gate driver output is not supplied, the active shutdown circuit keeps the output voltage at a low level

3 Electrical characteristics and parameters

3.1 Absolute Maximum Ratings

Table 3 Absolute Maximum Ratings

Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only. Operating the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Device reliability may be affected by exposure to absolute-maximum-rated conditions for extended periods of time.

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Average Input Current	$I_F(\text{AVG})$			20	mA	
Peak Transient Input Current	$I_F(\text{TRAN})$			1	A	<1 μs pulse width, 300pps
Reverse Input Voltage	$V_R(\text{MAX})$			18	V	
Power supply output side voltage	V_{VCC}	-0.3		35	V	$V_{VCC} - V_{VEE}$
Gate driver output voltage	V_{OUT}	$V_{VEE} - 0.3$		$V_{VCC} + 0.3$	V	
Input to output offset voltage	V_{OFFSET}			2300	V	¹⁾ $V_{OFFSET} = V_{VEE} - V_{CATHODE} $
ESD robustness - human body model	$ V_{ESD,HBM} $			8	kV	²⁾
ESD robustness - charged device model	ESD,CDM			TC1500		³⁾
Junction temperature	T_J	-40		150	°C	
Storage temperature	T_{Stg}	-55		150	°C	

PG-LDSOW-6

Power dissipation (input side)	$P_{D,IN}$			100	mW	⁴⁾ $T_A = 85 \text{ }^\circ\text{C}$
Power dissipation (output side)	$P_{D,OUT}$			500	mW	⁵⁾ $T_A = 85 \text{ }^\circ\text{C}$
Thermal resistance junction to ambient	$R_{THJA,OUT}$			129	K/W	$T_A = 85 \text{ }^\circ\text{C}$, 2s2p - no vias, $P_J = 500 \text{ mW}$
Characterization parameter junction to package top	Ψ_{Jtop}			6.1	K/W	$T_A = 85 \text{ }^\circ\text{C}$, 2s2p - no vias, $P_J = 500 \text{ mW}$

1) for functional operation only

2) According to ANSI/ESDA/JEDEC-JS-001-2017 (discharging a 100 pF capacitor through a 1.5 k Ω series resistor)

3) According to ANSI/ESDA/JEDEC-JS-002-2014 (TC = test condition in volt)

4) IC input-side power dissipation is derated linearly with 7.75 mW/°C above 137.1 °C

5) IC output-side power dissipation is derated linearly with 7.75 mW/°C above 85 °C

3.2 Recommended operating conditions

Table 4 Recommended operating conditions

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Power supply output side voltage	V_{VCC}	9.6		32	V	$V_{VCC} - V_{VEE}$, 1ED3010
Power supply output side voltage	V_{VCC}	12.35		32	V	$V_{VCC} - V_{VEE}$, 1ED3011
Power supply output side voltage	V_{VCC}	14		32	V	$V_{VCC} - V_{VEE}$, 1ED3012
Input diode forward current (Diode "ON")	$I_{F(ON)}$	5.5		15	mA	
Input voltage (Diode "OFF")	$V_{F(OFF)}$	-15		0.9	V	
Ambient temperature	T_A	-40		125	°C	
Junction temperature	T_J	-40		150	°C	

3.3 Electrical characteristics

The electrical characteristics include the spread of values over supply voltages, input currents and temperatures within the recommended operating conditions ($T_J = -40$ °C to 150 °C, $I_{F(ON)} = 5.5$ mA to 15 mA, $V_{F(OFF)} = -15$ V to 0.9 V). Electrical characteristics are tested in production at $T_A = 25$ °C. Typical values represent the median values measured at $V_{VCC} - V_{VEE} = 15$ V and $T_A = 25$ °C unless otherwise specified. Minimum and maximum values in characteristics are verified by characterization/design. This is valid for all electrical characteristics unless otherwise specified.

3.3.1 Power supply

Table 5 Power supply

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Quiescent current output side, ON state	$I_{Q,ON}$			1.35	mA	$I_F = I_{F(ON)}$, $V_{VCC} - V_{VEE} = 15$ V
Quiescent current output side, OFF state	$I_{Q,OFF}$			1.0	mA	$V_F = 0$ V, $V_{VCC} - V_{VEE} = 15$ V

1ED3010

UVLO threshold output side (on)	V_{UVLOH}		9.3	9.6	V	$V_{VCC} - V_{VEE}$
UVLO threshold output side (off)	V_{UVLOL}	8.25	8.55		V	$V_{VCC} - V_{VEE}$
UVLO hysteresis output side	V_{HYS}		0.75		V	$V_{UVLOH} - V_{UVLOL}$

1ED3011

UVLO threshold output side (on)	V_{UVLOH}		12	12.35	V	$V_{VCC} - V_{VEE}$
UVLO threshold output side (off)	V_{UVLOL}	10.7	11.05		V	$V_{VCC} - V_{VEE}$
UVLO hysteresis output side	V_{HYS}		0.95		V	$V_{UVLOH} - V_{UVLOL}$

1ED3012

UVLO threshold output side (on)	V_{UVLOH}		13.6	14	V	$V_{VCC} - V_{VEE}$
UVLO threshold output side (off)	V_{UVLOL}	12.15	12.55		V	$V_{VCC} - V_{VEE}$
UVLO hysteresis output side	V_{HYS}		1.05		V	$V_{UVLOH} - V_{UVLOL}$

3.3.2 Input

Table 6 Input

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Threshold input forward current low to high	I_{FLH}			4.5	mA	$V_{OUT} > 5 \text{ V}$, $C_L = 1 \text{ nF}$
Input forward voltage	V_F		2.35	2.65	V	$I_F = 5.5 \text{ mA}$
Input forward voltage	V_F	2.65	3.2		V	$I_F = 15 \text{ mA}$
Threshold input voltage high to low	V_{FHL}	0.9			V	$V_{OUT} < 5 \text{ V}$, $C_L = 1 \text{ nF}$
Temperature coefficient of input forward voltage	$\Delta V_F / \Delta T$	-1.5		1.5	mV/°C	
Input reverse breakdown voltage	V_R	20			V	$I_R = 10 \mu\text{A}$

3.3.3 Gate driver

Table 7 Gate driver

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
High level output peak current	I_{OUTH}	3.5	6		A	¹⁾ $V_{VCC} - V_{VEE} = 15 \text{ V}$, $I_F = I_{F(ON)}$, $C_L = 100 \text{ nF}$
High level output on resistance	$R_{DSON,H}$	0.3	0.9	2.1	Ω	$I_{OUTH} = 0.1 \text{ A}$
Low level output peak current	I_{OUTL}	3.5	6.5		A	¹⁾ $V_{VCC} - V_{VEE} = 15 \text{ V}$, $V_F = 0 \text{ V}$, $C_L = 100 \text{ nF}$
Low level output on resistance	$R_{DSON,L}$	0.2	0.5	1.1	Ω	$I_{OUTL} = 0.1 \text{ A}$
Short circuit clamp voltage between OUT and VCC	$V_{CLP,OUT}$			1.0	V	$V_{OUT} - V_{VCC}$, $I_{OUT(H)} = -500 \text{ mA}$, $t < 10 \mu\text{s}$, $I_F = I_{F(ON)}$
Clamp voltage between VEE and OUT	$V_{CLP,OUT}$			1.0	V	$V_{VEE} - V_{OUT}$, $I_{OUT} = -500 \text{ mA}$, $t < 10 \mu\text{s}$, $V_F = 0 \text{ V}$

1) Parameter is not subject to production test - verified by design/characterization

3.3.4 Dynamic characteristics

Table 8 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Input to output propagation delay ON	t_{PDON}	19	32	40	ns	$V_{VCC} - V_{VEE} = 15 \text{ V}$, $C_L = 100 \text{ pF}$, valid for 1ED3010 and 1ED3011 only
Input to output propagation delay ON	t_{PDON}	19	32	40	ns	$V_{VCC} - V_{VEE} = 18 \text{ V}$, $C_L = 100 \text{ pF}$, valid for 1ED3012 only

(table continues...)

Table 8 (continued) Dynamic characteristics

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Input to output propagation delay OFF	$t_{PD OFF}$	15	25	30	ns	$V_{VCC} - V_{VEE} = 15 \text{ V}$, $C_L = 100 \text{ pF}$, valid for 1ED3010 and 1ED3011 only
Input to output propagation delay OFF	$t_{PD OFF}$	15	25	30	ns	$V_{VCC} - V_{VEE} = 18 \text{ V}$, $C_L = 100 \text{ pF}$, valid for 1ED3012 only
Input to output propagation delay distortion	$ t_{PDISTO} $		7	15	ns	¹⁾ $ t_{PD OFF} - t_{PD ON} $, $t_{ON} > 100 \text{ ns}$ and $t_{OFF} > 100 \text{ ns}$
Input to output, part to part skew	t_{SKew}			10	ns	^{1) 2)} $C_L = 100 \text{ pF}$, same input signal
Input to output, part to part skew plus	t_{SKew+}			17	ns	^{1) 2)} $C_L = 100 \text{ pF}$, complementary input signals
Rise time	t_{RISE}			15	ns	$V_{VCC} - V_{VEE} = 15 \text{ V}$, $C_L = 1 \text{ nF}$, valid for 1ED3010 and 1ED3011 only
Rise time	t_{RISE}			15	ns	$V_{VCC} - V_{VEE} = 18 \text{ V}$, $C_L = 1 \text{ nF}$, valid for 1ED3012 only
Fall time	t_{FALL}			15	ns	$V_{VCC} - V_{VEE} = 15 \text{ V}$, $C_L = 1 \text{ nF}$, valid for 1ED3010 and 1ED3011 only
Fall time	t_{FALL}			15	ns	$V_{VCC} - V_{VEE} = 18 \text{ V}$, $C_L = 1 \text{ nF}$, valid for 1ED3012 only
Output-side start-up time	$t_{START,VCC}$		5	10	μs	²⁾ $I_F = I_{F(ON)}$, $C_L = 100 \text{ pF}$
Output-side deactivation time	$t_{STOP,VCC}$	0.5		1.5	μs	²⁾ $I_F = I_{F(ON)}$, $C_L = 100 \text{ pF}$
High-level common-mode transient immunity	$ CM_H $	300			$\text{kV}/\mu\text{s}$	²⁾ $V_{CM} = 1500 \text{ V}$, $I_F = I_{F(ON)}$
Low-level common-mode transient immunity	$ CM_L $	300			$\text{kV}/\mu\text{s}$	²⁾ $V_{CM} = 1500 \text{ V}$, $V_F = 0 \text{ V}$

1) Value at same ambient temperature and supply voltage

2) Parameter is not subject to production test - verified by design/characterization

3.3.5 Active shut down

Table 9 Active shut down

Parameter	Symbol	Values			Unit	Note or condition
		Min.	Typ.	Max.		
Active shut down voltage	V_{ACTSD}			1.8	V	$V_{OUT} - V_{VEE}$, $I_{OUTL} = 500 \text{ mA}$, VCC open

4 Insulation characteristics (IEC 60747-17, UL 1577) for LDSO-6 300 mil package

This coupler is suitable for rated insulation only within the given safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

Table 10 Insulation specification for LDSO-6 300 mil package

Description	Symbol	Characteristic	Unit
Safety limiting values			
Maximum ambient safety temperature	T_S	150	°C
Maximum input-side power dissipation at $T_A = 25^\circ\text{C}$ ¹⁾	P_{SI}	100	mW
Maximum output-side power dissipation at $T_A = 25^\circ\text{C}$ ²⁾	P_{SO}	1000	mW
Package specific insulation characteristics			
External clearance	CLR	> 8	mm
External creepage	CPG	> 8	mm
Comparative tracking index	CTI	> 600	–
Isolation capacitance	C_{IO}	0.9	pF
Reinforced insulation according to IEC 60747-17 planned			
Installation classification per IEC 60664-1, Table F.1			–
for rated mains voltage $\leq 150 \text{ V (rms)}$		I-IV	
for rated mains voltage $\leq 300 \text{ V (rms)}$		I-IV	
for rated mains voltage $\leq 600 \text{ V (rms)}$		I-III	
for rated mains voltage $\leq 1000 \text{ V (rms)}$		I-II	
Climatic classification		40/125/21	–
Pollution degree (IEC 60664-1)		2	–
Apparent charge, method a	q_{pd}	< 5	pC
$V_{pd(ini),a} = V_{IOTM}$, $V_{pd(m)} = 1.6 \times V_{IORM}$, $t_{ini} = 1 \text{ min}$, $t_m = 10 \text{ s}$			
Apparent charge, method b	q_{pd}	< 5	pC
$V_{pd(ini),b} = V_{IOTM} \times 1.2$, $V_{pd(m)} = 1.875 \times V_{IORM}$, $t_{ini} = 1 \text{ s}$, $t_m = 1 \text{ s}$			
Isolation resistance at $T_{A,\text{max}}$; $V_{IO} = 500 \text{ V}_{\text{DC}}$, $T_A = 125^\circ\text{C}$	R_{IO}	$> 10^{11}$	Ω
Isolation resistance at T_S ; $V_{IO} = 500 \text{ V}_{\text{DC}}$, $T_S = 150^\circ\text{C}$	R_{IO_S}	$> 10^9$	Ω
Maximum rated transient isolation voltage	V_{IOTM}	8000	V (peak)
Maximum repetitive isolation voltage	V_{IORM}	1767	V (peak)
Maximum working isolation voltage	V_{IOWM}	1250	V (rms)
Impulse voltage	V_{IMP}	8000	V (peak)
Maximum surge isolation voltage for reinforced isolation; $V_{TEST} \geq V_{IMP} \times 1.3$	V_{IOSM}	11000	V (peak)
Recognized under UL 1577			
Insulation withstand voltage (60 s)	V_{ISO}	5700	V (rms)
Insulation test voltage (1 s)	$V_{ISO,TEST}$	6840	V (rms)

1) IC input-side power dissipation is derated linearly at 2 mW/°C above 159 °C

2) IC output-side power dissipation is derated linearly at 8 mW/°C above 65 °C

5 Parameter measurement

5.1 Propagation delay, rise and fall time

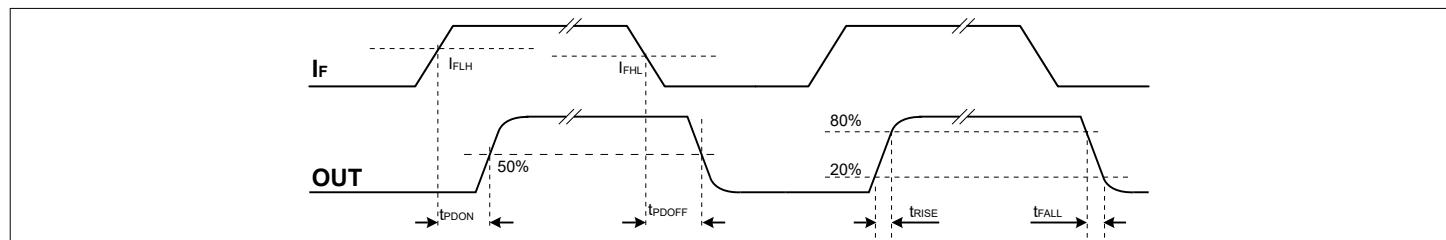


Figure 3 Propagation delay, rise time and fall time

5.2 Part to part skew and skew+

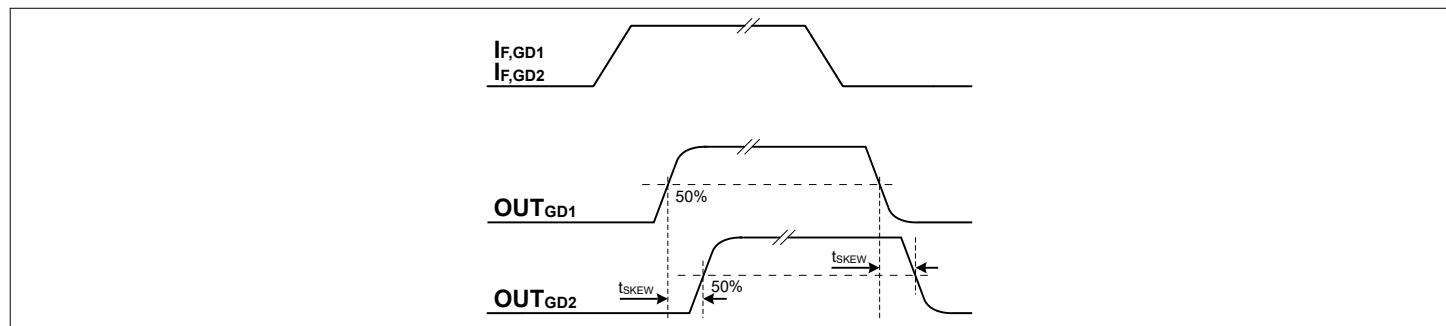


Figure 4 Input to output, part to part skew

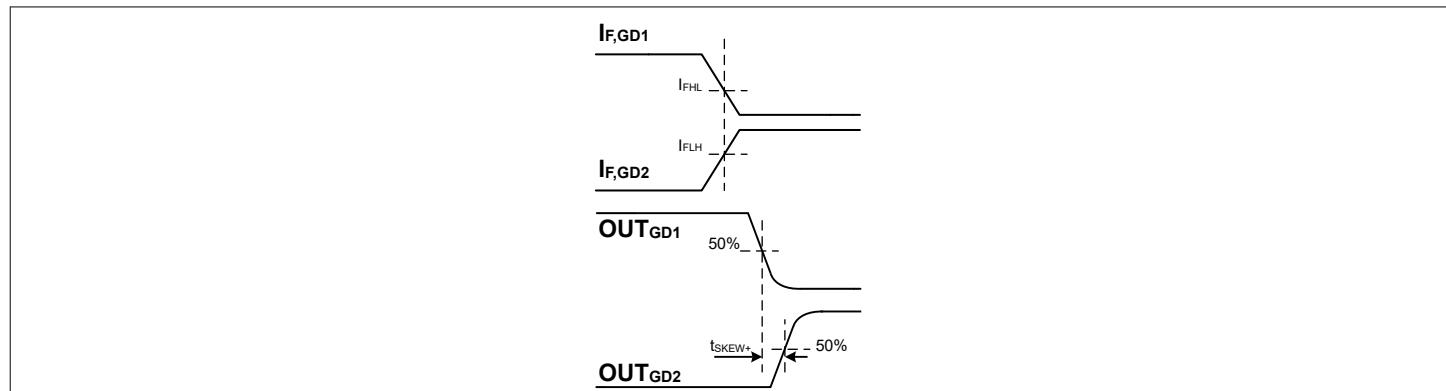


Figure 5 Input to output, part to part skew+

5.3 Undervoltage lockout (UVLO)

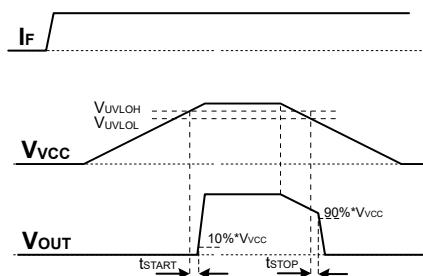


Figure 6 UVLO Behavior

To ensure correct switching of the IGBT, Si or SiC MOSFET, the device is equipped with an undervoltage lockout for the output side. Operation starts only after the supply voltage level has increased beyond the V_{UVLOL} level.

If the power supply voltage V_{VCC} of the output chip goes down below V_{UVLOL} the IGBT, Si or SiC MOSFET is switched off and signals from the input chip are ignored until V_{VCC} reaches the power-up voltage V_{UVLOH} again.

Note: V_{VCC} is always referred to VEE and does not differentiate between unipolar or bipolar supply.

5.4 CMTI measurement setup

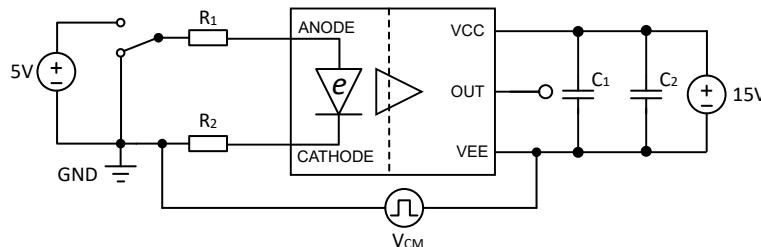


Figure 7 CMTI Test circuit

6 Functional description

The EiceDRIVER™ 1ED301xMC12I gate driver ICs are compact, general purpose gate drivers for IGBTs and MOSFETs. They are offered in an industry standard 6 pin (SO6) package with >8 mm creepage and clearance and are pin compatible with standard opto-isolated gate drivers. They offer basic control and protection features enabling fast and easy design of highly reliable systems.

The integrated galvanic isolation via coreless transformer, between the input control side and the driving output stage, provides reinforced isolation and moreover offers best-in-class common mode transient immunity of >300 kV/ μ s.

The input stage of the 1ED301xMC12I family uses an emulated diode which does not use light emission to transmit signals across the isolation barrier and is therefore providing several advantages over standard opto-isolated gate drivers:

- Best in class common mode transient immunity
- Best in class propagation delay and part to part matching (skew and skew+)
- Best in class pulse distortion and part to part skew in the propagation delay, making the design suitable for high performance applications using SiC MOSFETs
- Superior reliability and aging characteristics to those of standard opto-isolated gate drivers who use light emission for their operation

6.1 Input features

The input stage of the gate driver is made to emulate a diode and therefore has two connections: the *ANODE* (Pin 1) and the *CATHODE* (Pin 3).

When the emulated diode is forward biased, meaning a positive voltage is applied between *ANODE* and *CATHODE*, a forward current I_F flows through it. If this current is above the threshold I_{FLH} , the transmitter is activated and this leads to the gate driver output being driven high. An external resistor is recommended in order to limit the forward current to a range between the recommended values. If the *ANODE* drops below the threshold V_{FHL} or is reversed biased with respect to the *CATHODE*, the gate driver output is driven low. The large allowable reverse voltage enables the gate driver to be operated in interlock architecture.

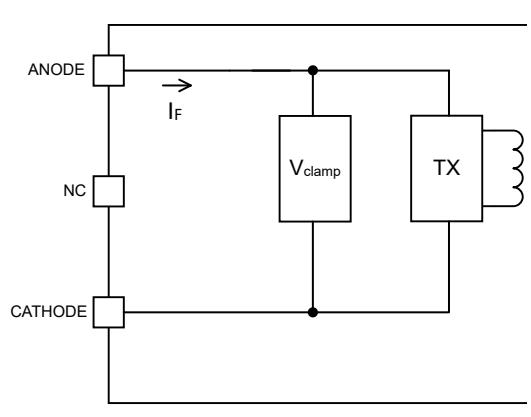


Figure 8 Block diagram of input section

The gate driver IC input section consists of the following functional blocks:

- reverse voltage blocking element
- forward voltage clamping element
- isolated signal transmitter to the output section

6.2 Output features

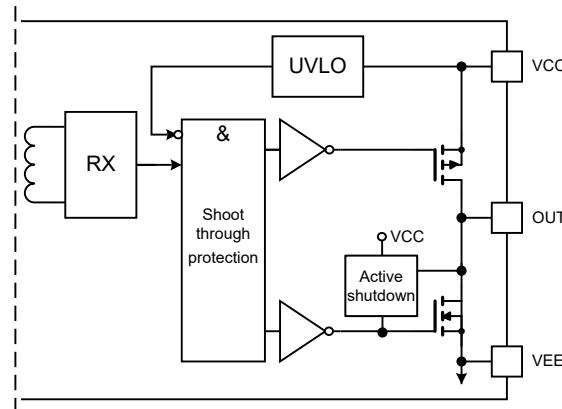
This section describes the gate driver output sections. The output features of the gate driver IC include undervoltage lockout for the output supply, shoot through protection circuitry for the internal output stage and the active shutdown circuitry.

The current sourcing stage design of the gate driver ICs is designed with a PMOS-only MOSFET. The PMOS will deliver a strong current, not only at the beginning, but constantly all the way up to the *VCC* rail, ensuring a fast turn-on of the IGBT, Si or SiC MOSFET.

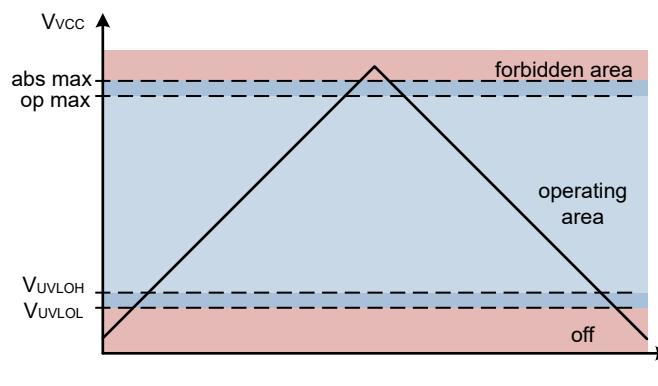
Figure 9 Block diagram of output section

The gate driver IC output section consists of the following functional blocks:

- output undervoltage lockout circuit
- isolated signal receiver from the input section
- sourcing and sinking output stage
- active shutdown circuitry


6.2.1 Output undervoltage lockout (UVLO)

The output supply range has a positive absolute maximum rating of 35 V for all variants. The gate driver ICs are therefore capable of providing a bipolar gate voltage to a connected power switch.


Figure 10 Output supply and UVLO threshold

At a crossing of the turn on undervoltage lockout threshold (V_{UVLOH}) during a positive ramp at V_{CC} pin in relation to the VEE pin, the output section starts operating. The commands from the input side of the gate driver are received and evaluated at the output side. During V_{CC} ramp down and crossing of the turn-off undervoltage lockout threshold (V_{UVLOL}), the output section will initiate a turn-off command regardless of the commands received from the input section. The hysteresis between the thresholds V_{UVLOL} and V_{UVLOH} ensures stable operation when the supply voltage is close to the threshold levels.

Any voltage overshoot above the absolute maximum voltage rating can damage the driver circuits. The operating area is defined between the turn-on undervoltage lockout threshold (V_{UVLOH}) and the maximum recommended operating voltage.

6.2.2 Active shutdown

The active shutdown function is a protection feature of the driver. It is designed to avoid a free-floating gate of a connected power switch to trigger a turn-on.

The active shutdown feature ensures a safe IGBT, Si or SiC MOSFET off-state in case the output chip is not connected to the power supply or an undervoltage lockout is in effect. The IGBT, Si or SiC MOSFET gate is clamped via the *OUT*-pin to *VEE*.

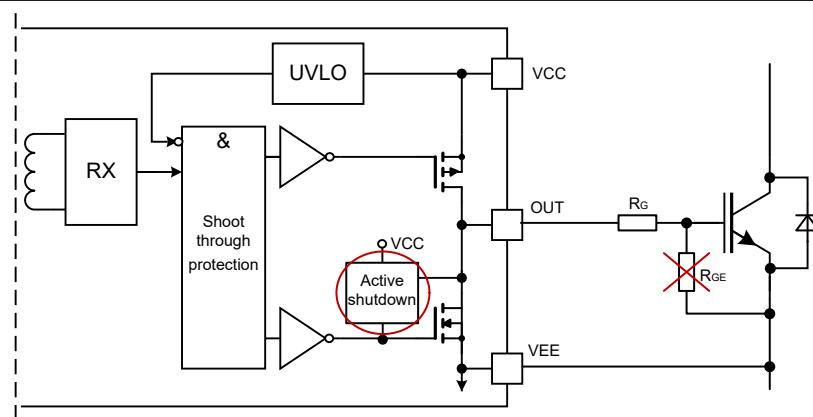


Figure 11 Block diagram showing active shutdown

In case of a missing or collapsing power supply at the *VCC* pin, the output section of the driver operates in the active shutdown mode. In this case the driver uses the floating voltage of the connected gate to supply this internal circuit. This solution is by far stronger than using the external R_{GE} . At the same time, fast dV/dt events on the switch can generate miller currents that could bias the gate, even when the gate driver is not powered on. Also in this case the active shutdown circuit will use the voltage to self power and actively pull the gate low.

6.2.3 Driver outputs and supply

The output driver section uses MOSFETs to provide a rail-to-rail output. This feature permits that tight control of gate voltage during on-state and short circuit can be maintained as long as the driver's supply is stable. Due to the low internal voltage drop, switching behavior of the IGBT, Si or SiC MOSFET is predominantly governed by the gate resistor for as long as the current rating of the gate driver is not exceeded. Furthermore, it reduces the power to be dissipated by the driver as most of the energy is dissipated in the gate resistor.

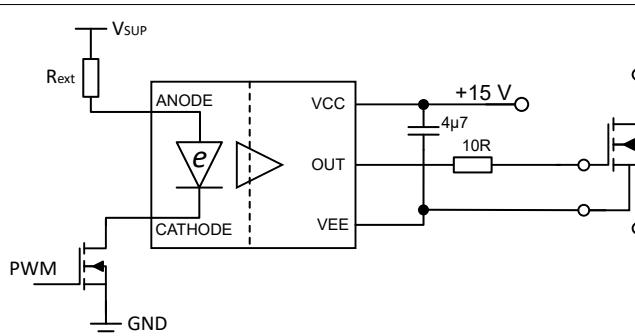


Figure 12 Circuit example for unipolar power supply driving SiC MOSFET

When driving the switch with unipolar power supplies, the *VEE* pin should be connected directly to the source or emitter of the power transistor as shown in [Figure 12](#).

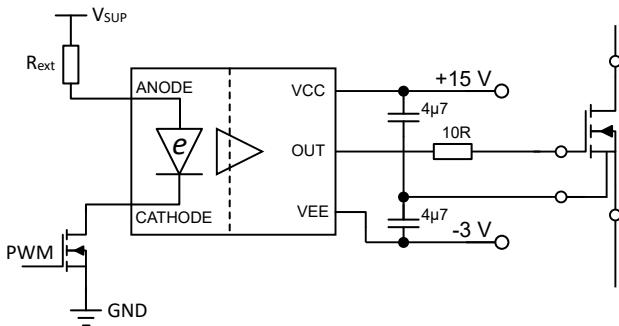


Figure 13 Circuit example for bipolar power supply driving SiC MOSFET

When driving the switch with bipolar power supplies, a virtual ground should be created between two capacitors connected to the *VCC* and *VEE* pins. This virtual ground should then be connected to the source or emitter of the power transistor as shown in [Figure 13](#).

7 Application information

Note: Infineon is providing this information as a courtesy only and without acknowledging any legal obligation. Information in the following application chapters is not part of the Infineon component specification, and Infineon does not warrant its accuracy or completeness. Infineon's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality

7.1 Input resistor selection

The input resistor limits the current through the emulated diode when it is forward biased and ensures that the forward current, when the emulated diode is on, stays inside the recommended operating range.

There are several design aspects that need to be taken into consideration when selecting the input resistor:

- Supply voltage V_{SUP} variation
- Emulated diode forward voltage drop variation
- Manufacturer's tolerance for the resistor

In order to calculate the maximum allowed resistor value for a $V_{SUP} = 3.3$ V nominal, the following assumptions are made:

- the supply voltage is 5% below the nominal value of 3.3 V
- the forward voltage drop of the emulated diode is at its maximum value for 5.5 mA

The maximum allowed resistor value will therefore be given by:

$$R_{in, max} = \frac{V_{SUP, min} - V_{F, max}}{I_{F, min}} = \frac{3.135V - 2.65V}{5.5mA} \approx 88\Omega \quad (1)$$

In order to calculate the minimum allowed resistor value for a $V_{SUP} = 3.3$ V nominal, the following assumptions are made:

- the supply voltage is 5% above the nominal value of 3.3 V
- the forward voltage drop of the emulated diode is at its minimum value for 15 mA

The minimum allowed resistor value will therefore be given by:

$$R_{in, min} = \frac{V_{SUP, max} - V_{F, min}}{I_{F, max}} = \frac{3.465V - 2.65V}{15mA} \approx 55\Omega \quad (2)$$

The chosen input resistor value, taking into account tolerances as well, should be between these limit values:

$$R_{in, min} \leq R_{in, chosen} \leq R_{in, max} \quad (3)$$

For a supply voltage on the input side of 3.3 V nominal, a 68 Ω resistor with 1% tolerance is recommended. This value does not take into consideration any resistance of the buffer or the transistor used to drive the input stage of the gate driver. In case this resistance is significant compared to the total external resistance, it should be subtracted from the chosen value for the external resistor.

7.2 Gate resistor selection

The gate resistor is a key component in the gate drive circuit. The gate resistor limits the source and the sink current of the gate driver thereby exercising control over the switching speed of the associated power transistor during both turn-on and turn-off operations. As such, the careful selection of an appropriate gate resistor represents a vital consideration in the design process. Some important considerations for selection of the gate resistance are to:

- Optimize the switching losses
- Limit the overshoots and oscillations of the drain source voltage or the collector emitter voltage of the power transistor during turn-off
- Limit the overshoot and oscillations of the drain current or collector current during turn-on
- Damp the oscillations of the gate source or gate emitter voltage caused by parasitic inductances and capacitances in the gate loop

As a starting point in the gate driver selection, the gate resistor used in the datasheet of the power transistor for the characterization of turn-on and turn-off losses can be used. The power supply conditions are rarely the same as the power supply conditions used in power transistor datasheets. Therefore, an adaptation of the power transistor datasheet values is required to obtain a starting point to optimize of the final gate resistor. The method proposed here uses the same peak gate current value for both the actual application and the power transistor datasheet.

The peak gate current as per power transistor datasheet equals to:

$$I_{G, pk} = \frac{\Delta V_{GS}}{R_{G, datasheet} + R_{G, int}} = \frac{\Delta V_{GS}}{R_{G, application} + R_{G, int}} \quad (4)$$

with $\Delta V_{GS} = V_{VCC} - V_{VEE}$

Solving this equation for R_G leads to:

$$R_G = \frac{\Delta V_{GS}}{I_{G, pk}} - R_{G, int} \quad (5)$$

This method results in a starting point for the gate resistor selection. Further evaluations, such as EMI measurements, are required for the final dimensioning of the gate resistors as they have to be adjusted to work with the circuitry inductance, margins and allowed dV/dt transients.

7.3 Power supply recommendations

The 1ED301x gate drivers support a wide range of voltages on the output side. These devices can operate with unipolar as well as bipolar power supply voltages on the output side for reliable and safe operation in the application. To ensure that the gate driver operates correctly, it is necessary to place appropriate decoupling capacitors on the power supply pins.

The decoupling capacitors on the output side, in addition to decoupling any disturbance on the power supply, also store the energy necessary to deliver the gate currents required for turning on and off the power transistor. Therefore, these capacitors should be dimensioned appropriately to limit the voltage drop during the power transistor turn-on and turn-off process.

When using a unipolar power supply, a low ESR, surface mount, multilayer ceramic capacitor of proper value should be placed between the *VCC* pin and the *VEE* pin, in close proximity of the pins.

In case of bipolar power supply, using a ceramic capacitor of proper value between *VCC* and virtual ground (source or emitter potential of power transistor) is recommended. Similarly, using a capacitor between *VEE* pin and virtual ground is recommended. Depending on the gate charge of the power transistor and the peak source and sink gate currents, a higher capacitance may be necessary to limit the voltage drop during power transistor turn-on and turn-off. Finally, a 100 nF decoupling capacitor is recommended between the *VCC* and *VEE* pins to ensure a short path between them to decouple any high frequency noise.

When selecting the capacitors, it is important to consider the capacitance drop of ceramic capacitors with respect to the applied DC voltage.

7.4 Power dissipation estimation

The gate driver output side losses consist of the quiescent current losses P_Q at nominal switching frequency and no load, the sourcing losses P_{source} and the sinking losses P_{sink} :

$$P_{\text{OUT}} = P_Q + P_{\text{source}} + P_{\text{sink}} \quad (6)$$

The turn-on, P_{source} , and turn-off, P_{sink} , losses can be estimated using the inner gate driver resistance, $R_{\text{DSON,H}}$ or $R_{\text{DSON,L}}$, the external gate resistor, $R_{G,\text{ext}}$ and, if applicable, the internal gate resistor of the switch $R_{G,\text{int}}$, the application related gate charge, Q_G , the total gate driving voltage, $V_{\text{VCC}} - V_{\text{VEE}}$, and switching frequency, f_{sw} :

$$\begin{aligned} P_{\text{source}} &= \frac{1}{2} Q_G \cdot f_{\text{sw}} \cdot (V_{\text{VCC}} - V_{\text{VEE}}) \cdot \frac{R_{\text{DSON,H}}}{R_{\text{DSON,H}} + R_{G,\text{ext,ON}} + R_{G,\text{int}}} \\ P_{\text{sink}} &= \frac{1}{2} Q_G \cdot f_{\text{sw}} \cdot (V_{\text{VCC}} - V_{\text{VEE}}) \cdot \frac{R_{\text{DSON,L}}}{R_{\text{DSON,L}} + R_{G,\text{ext,OFF}} + R_{G,\text{int}}} \end{aligned} \quad (7)$$

Additionally, external components that surround the gate driver can heat up the IC. The mere calculation of losses and the theoretical junction temperature alone are not sufficient for a proven gate driver circuit design. A verification by measurement is needed to avoid unexpected effects in the application. The identification of hot spots is possible, for example, by using an infrared camera.

8 Package dimensions

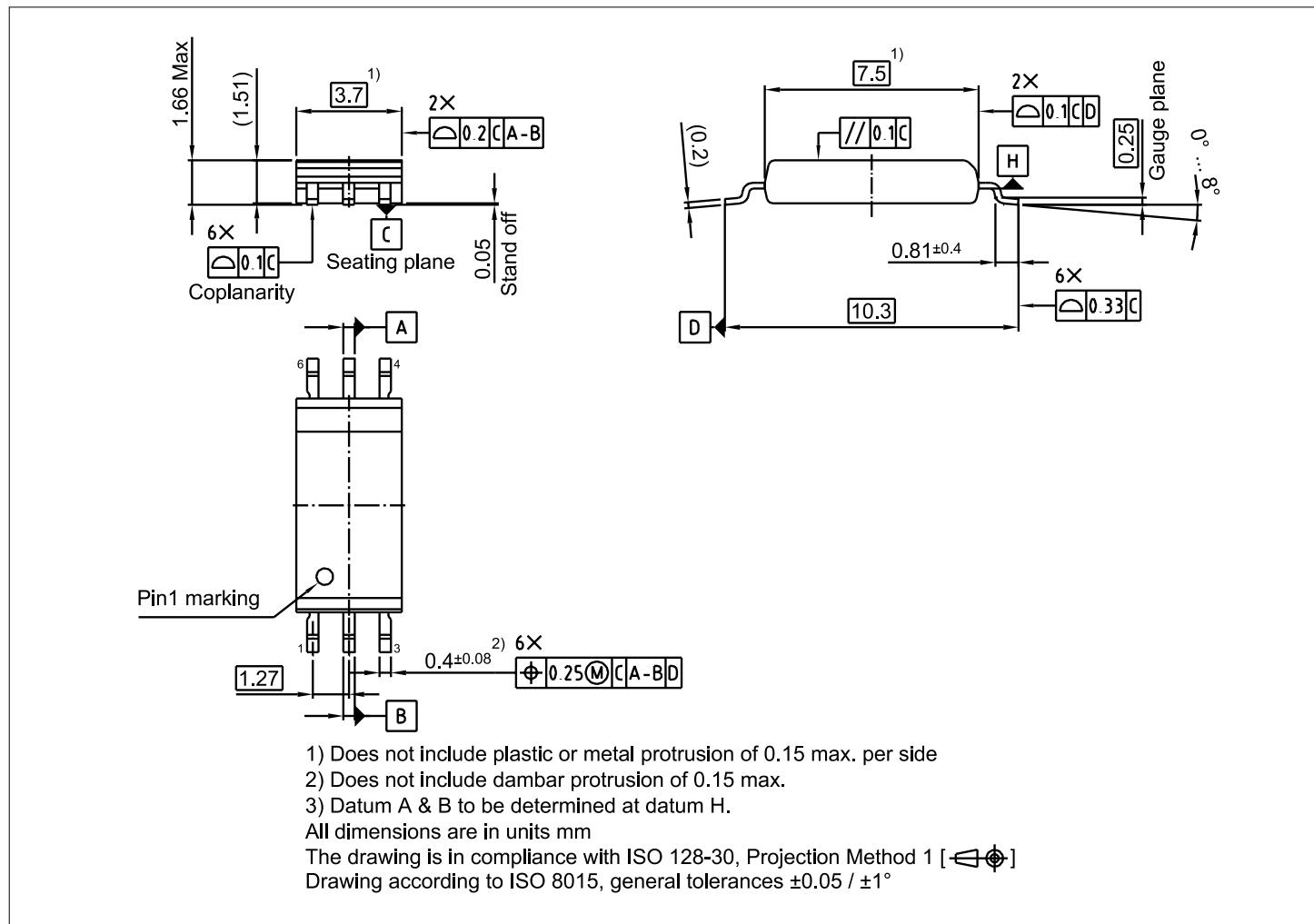


Figure 14

LDSO-6 300 mil (low profile dual small outline package wide form factor, 300 mil)

8 Package dimensions

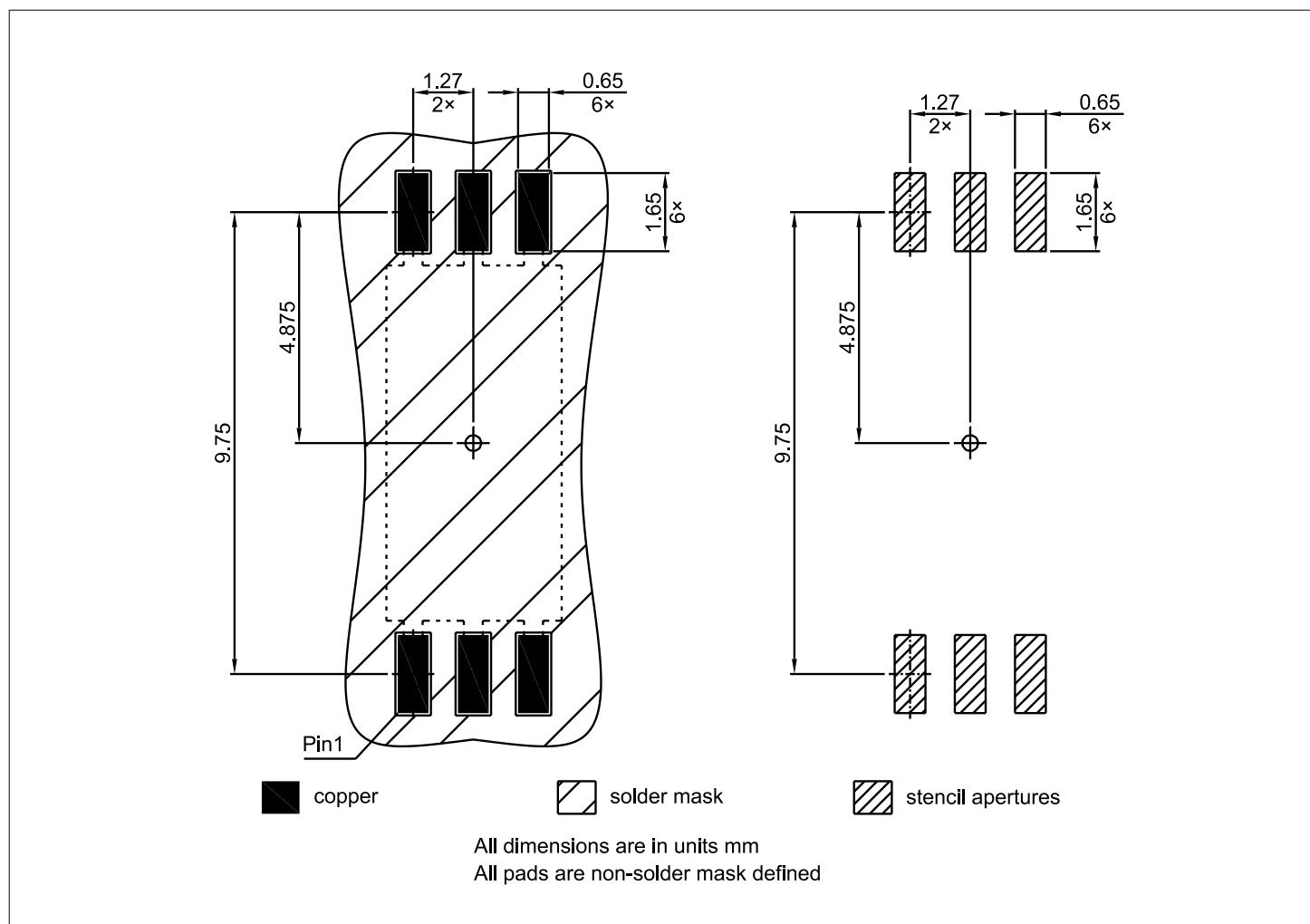


Figure 15

LDSO-6 300 mil recommended footprint

Revision history

Document version	Date of release	Description of changes
v 0.60	2025-04-29	<ul style="list-style-type: none">updated values for t_{PDON}, t_{PDOFF}, t_{PDISTO}, t_{SKEW+}, t_{RISE}, t_{FALL}, $t_{STOP,VCC}$
v 0.50	2025-03-27	<ul style="list-style-type: none">preliminary version

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